TOSHIBA CMOS DIGITAL INTEGRATED CIRCUIT SILICON MONOLITHIC

# TC74HCT245AP, TC74HCT245AF, TC74HCT245AFW

#### **OCTAL BUS TRANSCEIVER (3-STATE)**

The TC74HCT245A is high speed CMOS OCTAL BUS TRANSCEIVER fabricated with silicon gate C2MOS technology.

It achieves the high speed operation similar to equivalent LSTTL while maintaining the CMOS low power dissipation. Its inputs are compatible with TTL, NMOS, and CMOS output voltage levels.

It is intended for two - way asynchronous communication between data busses. The direction of data transmission is determined by the level of the DIR input.

The enable input  $(\overline{G})$  can be used to disable the device so that the busses are effectively isolated.

All inputs are equipped with protection circuits against static discharge or transient excess voltage.

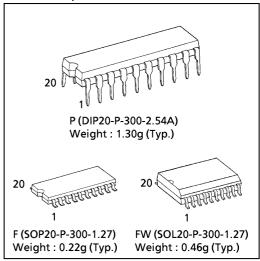
#### FEATURES:

- $\bullet$  High Speed------------------t\_{pd} = 10ns(typ.) at  $V_{CC}$  = 5V
- Low Power Dissipation ············· $I_{CC} = 4\mu A(Max.)$  at Ta = 25°C
- Compatible with TTL outputs  $\cdots$   $V_{IL} = 0.8V(Max.)$

 $V_{IH} = 2.0V(Min.)$ 

- Wide Interfacing ability .....LSTTL, NMOS, CMOS
- Output Drive Capability ...... 15 LSTTL Loads
- Symmetrical Output Impedance...  $|I_{OH}| = I_{OL} = 6mA(Min.)$
- Balanced Propagation Delays ····· t<sub>DLH</sub> ≃ t<sub>DHL</sub>
- Pin and Function Compatible with 74LS 245

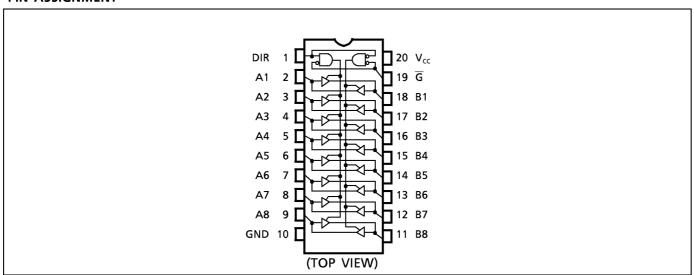
(Note) The JEDEC SOP (FW) is not available in Japan.



#### APPLICATION NOTES

1) Do not apply a signal to any bus terminal when it is the output mode. Damage may result.
2) All floating (high impedance) bus terminals must have their input levels fixed by means of pull up or down resistors.

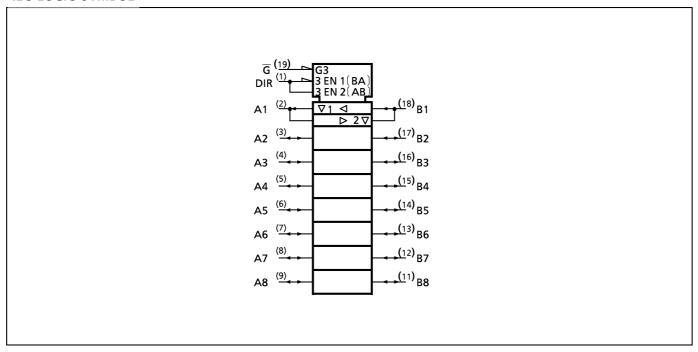
#### PIN ASSIGNMENT



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# **IEC LOGIC SYMBOL**



#### TRUTH TABLE

INID	LITC	FUNC		
INPUTS		FUNC	OUTPUT	
G	DIR	A BUS	B BUS	
L	Г	OUTPUT	INPUT	A = B
	H	INPUT	OUTPUT	B = A
Н	Х	High Im	Z	

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X: "H" or "L"

Z : High Impedance

# **ABSOLUTE MAXIMUM RATINGS**

PARAMETER	SYMBOL	VALUE	UNIT
Supply Voltage Range	V <sub>cc</sub>	−0.5~7	V
DC Input Voltage	V <sub>IN</sub>	$-0.5 \sim V_{CC} + 0.5$	V
DC Output Voltage	V <sub>OUT</sub>	-0.5~V <sub>CC</sub> + 0.5	٧
Input Diode Current	I <sub>IK</sub>	± 20	mA
Output Diode Current	I <sub>OK</sub>	± 20	mA
DC Output Current	I <sub>OUT</sub>	±35	mA
DC V <sub>CC</sub> / Ground Current	I <sub>cc</sub>	± 75	mA
Power Dissipation	P <sub>D</sub>	500 (DIP)* / 180 (SOP)	mW
Storage Temperature	T <sub>stg</sub>	<b>−65~150</b>	°C

<sup>\*500</sup>mW in the range of Ta= $-40^{\circ}\text{C}\sim65^{\circ}\text{C}$ . From Ta= $65^{\circ}\text{C}$  to 85 °C a derating factor of  $-10\text{mW}/^{\circ}\text{C}$  shall be applied until 300mW.

#### **RECOMMENDED OPERATING CONDITIONS**

PARAMETER	SYMBOL	VALUE	UNIT
Supply Voltage	V <sub>cc</sub>	4.5~5.5	V
Input Voltage	V <sub>IN</sub>	0~V <sub>cc</sub>	٧
Output Voltage	V <sub>OUT</sub>	0~V <sub>cc</sub>	V
Operating Temperature	T <sub>opr</sub>	<b>−40~85</b>	°C
Input Rise and Fall Time	t <sub>r</sub> , t <sub>f</sub>	0~500	ns

#### DC ELECTRICAL CHARACTERISTICS

PARAMETER	SYMBOL	TEST CONDITION		V <sub>CC</sub>	1	$Ta = 25^{\circ}C$			$Ta = -40 \sim 85^{\circ}C$	
FARAIVIETER	STIVIBUL			(v)	MIN.	TYP.	MAX.	MIN.	MAX.	UNIT
High - Level Input Voltage	V <sub>IH</sub>				2.0	_	_	2.0	_	V
Low - Level Input Voltage	VIL				_	_	0.8	_	0.8	V
High - Level Output Voltage	V <sub>OH</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	$I_{OH} = -20 \mu A$	4.5	4.4	4.5	_	4.4	_	- V - V
			$I_{OH} = -6 \text{ mA}$	4.5	4.18	4.31	_	4.13	_	
Low - Level	V <sub>OL</sub>	$V_{IN} = V_{IH} \text{ or } V_{IL}$	I <sub>OL</sub> = 20 μA	4.5	_	0.0	0.1	_	0.1	
Output Voltage			$I_{OL} = 6 \text{ mA}$	4.5	_	0.17	0.26	_	0.33	
3 - State Output Off - State Current	l <sub>oz</sub>	$V_{IN} = V_{IH} \text{ or } V_{IL}$ $V_{OUT} = V_{CC} \text{ or GND}$		5.5	_	_	±0.5	_	± 5.0	
Input Leakage Current	I <sub>I N</sub>	$V_{1N} = V_0$	5.5	_	_	± 0.1	_	± 1.0	$\mu$ A	
Quiescent Supply	I <sub>cc</sub>	$V_{1N} = V_{0}$	5.5	_		4.0	_	40.0		
Current	I <sub>C</sub>	Per input:V <sub>IN</sub> Other input:V	5.5	_	_	2.0	_	2.9	mA	

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# AC ELECTRICAL CHARACTERISTICS (Input $t_r = t_f = 6ns$ )

PARAMETER	SYMBOL	TEST CONDITION	CL (pF)	V <sub>CC</sub> (V)	Ta = 25°C		Ta = − 40~85°C		UNIT	
FARAIVIETER	STIVIBOL				MIN.	TYP.	MAX.	MIN.	MAX.	UNII
Output Transition Time	t <sub>TLH</sub> t <sub>THL</sub>		50	4.5 5.5	1 1	7 6	12 11	_ _	15 14	
Duamanation Dalou Time	t <sub>pLH</sub>		50	4.5 5.5	1 1	13 11	22 20	_ _	28 25	
Propagation Delay Time	t <sub>pHL</sub>		150	4.5 5.5	1 1	18 16	30 27	_ _	38 34	
3-State Output	t <sub>pZL</sub> t <sub>pZH</sub>	$R_L = 1k\Omega$	50	4.5 5.5	1 1	19 16	30 27	_	38 34	ns
Enable time			150	4.5 5.5	1 1	24 22	38 34		48 43	
3-State Output Disable time	t <sub>pLZ</sub>	$R_L = 1k\Omega$	50	4.5 5.5	- -	17 16	30 27	_ _	38 34	
Input Capacitance	C <sub>IN</sub>	DIR,G			_	5	10	_	10	
Output Capacitance	C <sub>I/O</sub>	An,Bn		·		13	_	_	_	pF
Power Dissipation Capacitance	C <sub>PD</sub>				-	41	_	_	_	P'

Note(1): C<sub>PD</sub> is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

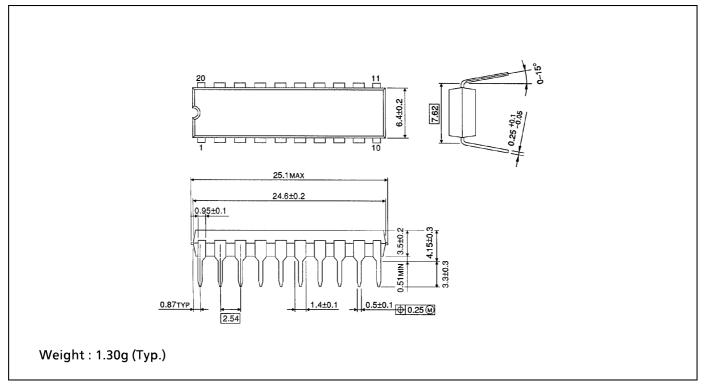
Average operating current can be obtained by the equation:

 $I_{CC}$  (opr) =  $C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC} / 8$  (per bit)

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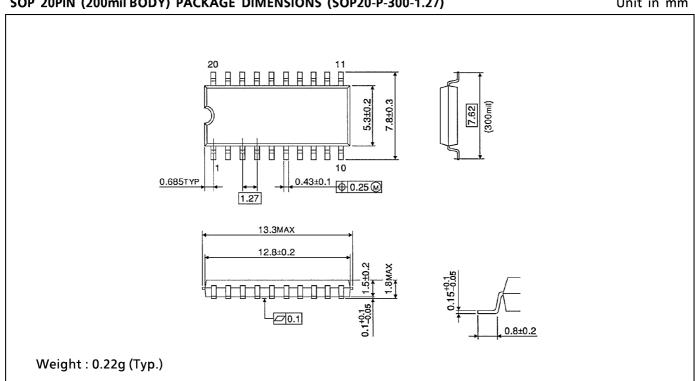
# DIP 20PIN PACKAGE DIMENSIONS (DIP20-P-300-2.54A)

Unit in mm



# SOP 20PIN (200mil BODY) PACKAGE DIMENSIONS (SOP20-P-300-1.27)

Unit in mm

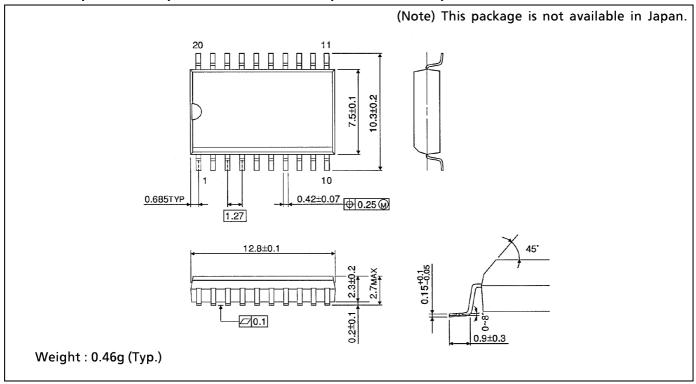


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# SOP 20PIN (300mil BODY) PACKAGE DIMENSIONS (SOL20-P-300-1.27)

Unit in mm



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